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# Carbon Nanotube Array Electrical Interfaces for Thermoelectrics

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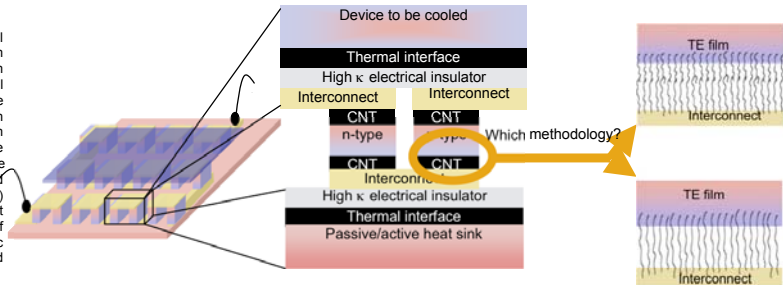
# Carbon Nanotube Array Electrical Interfaces for Thermoelectrics

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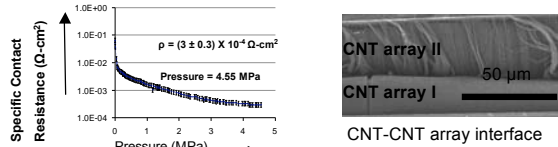
<sup>1</sup>School of Mechanical Engineering, <sup>2</sup>School of Materials Engineering, <sup>3</sup>School of Electrical and Computer Engineering, <sup>4</sup>Birck Nanotechnology Center, Purdue University

## 1. Thermomechanical compliance, electrical and thermal contact resistances in miniaturized thermoelectric devices

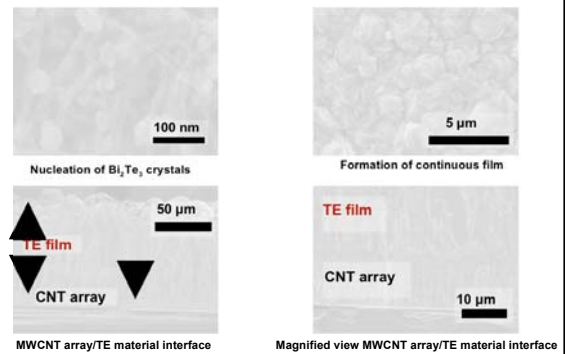
Miniaturized thermoelectric (TE) heat-pumps seem to be the ideal candidate for localized heat-flux dissipation challenges in microelectronics. It is unfortunate that despite of sustained research in this field, the realization of widespread TE applications in society still remains elusive. Here we report a new strategy to enhance the performance and reliability of TE devices by integrating TE films with carbon nanotube (CNT) arrays by an economical electrodeposition process. We demonstrate significant improvements in the thermomechanical compliance (increase in  $\Delta T_{max} > 200K$ ), and the electrical and thermal contact conductance of the CNT/TE integrated contact over the usual electrodeposited metal-interconnect/TE (M/TE) process. Improvements in thermomechanical compliance, and contact conductance at the M/CNT/TE contact will lead to development of various highly efficient and reliable applications like microelectronic cooling, waste heat recovery, precise temperature control and measurement, thermochemistry, etc.



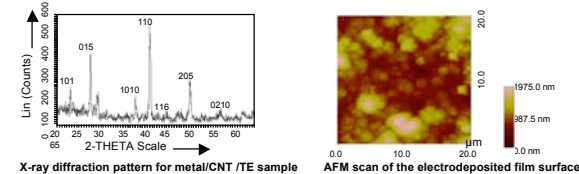
## 2. CNT-CNT array contact resistance



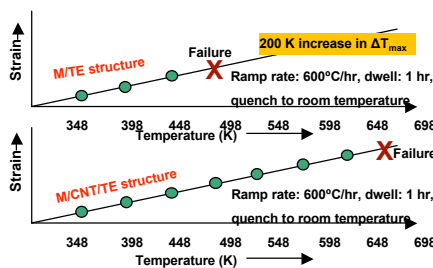
## 3 Electrodeposition process: Thin films of Bi<sub>2</sub>Te<sub>3</sub> were electrodeposited on the as-grown CNT array covered substrates in a standard three-cell potentiostat



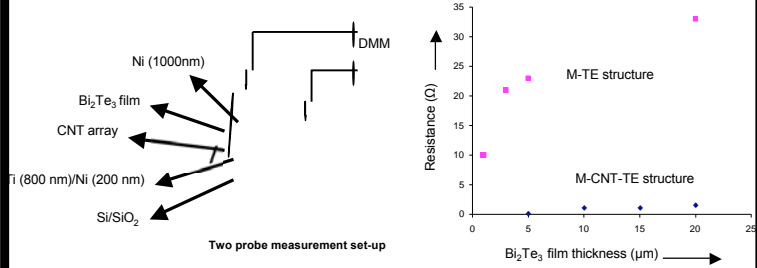
## 3(b). Polycrystalline Bi<sub>2</sub>Te<sub>3</sub> film characterization



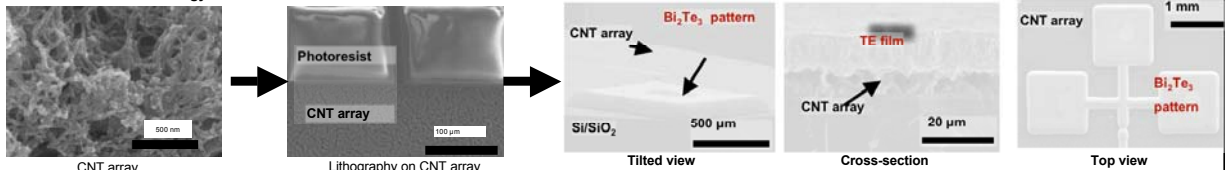
## 4 (a). Enhancement in thermomechanical compliance:



## 4(b). Effect on electrical contact conductance:



## 5. Device fabrication strategy:



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